

# Electronic Principles & Devices

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# Introduction to Electronics & Semiconductors & Diodes

## Basic Circuit elements



### Passive Elements

Resistor, Inductor, Capacitor

Resists flow of current thru it.  
Also will have voltage drop when measured across it.

Holds charge in form of magnetic field

Holds charge in form of electric field

### Active Elements

Voltage Source,  
Current Source

## V-I Characteristics of Resistor

$$V \propto I \Rightarrow V = IR$$

Unit  $\rightarrow \Omega$   
 $1 \Omega = 1 \text{ V/A}$

Ohm's Law

## V-I relation in capacitor

$$V \propto \int i dt \Rightarrow V = \frac{1}{C} \int_{t_0}^{t_1} i dt \Rightarrow i = C \frac{dv}{dt}$$

Capacitance  
SI unit : Farad (F)

## V-I relation in Inductor

$$V \propto \frac{di}{dt} \Rightarrow V = L \frac{di}{dt}$$

$$\Rightarrow i_L = \frac{1}{L} \int_{t_0}^{t_1} V_L dt$$

Inductance  
SI unit : Henry (H)

Q.  $V = 1.5V$   $I = 0.08A$   $R = ?$

A.  $R = \frac{V}{I} = \frac{1.5}{0.08} = \cancel{\frac{15}{8}} \quad 18.75\Omega \cancel{\neq}$

Q.  $V = 2.8V$   $I = 1.5A$   $R = ?$

A.  $R = \frac{V}{I} = \frac{2.8}{1.5} = \frac{5.6}{3} = 1.867\Omega$

Q.  $V = 3.99$   $I = 2.1A$   $R = ?$

A.  $R = \frac{V}{I} = \frac{3.99}{2.1} \frac{1.33}{0.7} = \frac{13.3}{7} = 1.9\Omega$

$$Q. \quad i(t) = 3.75 e^{-1.2t} A \quad ; \quad v(t) = 4 - 12.5 e^{-1.2t} V$$

$C = ?$

$$v(t) = \frac{1}{C} \int_0^t i(t) dt + v(0)$$

$$4 - 12.5 e^{-1.2t} = \frac{1}{C} \int_0^t 3.75 e^{-1.2t} dt + v(0)$$

$$= \frac{1}{C} \times \frac{3.75}{(-1.2)} e^{-1.2t} \Big|_0^t + v(0)$$

$$= -\frac{3.125}{C} (e^{-1.2t} - 1) + v(0)$$

$$\Rightarrow 12.5 = \frac{3.125}{C} \Rightarrow C = 0.25 F$$

$= 250 \text{ mF}$

$$Q. \quad i(t) = 3 - 4.5 e^{-6t} A$$

$$L = 2.5 \text{ H}$$

$$v(L) = L \frac{di}{dt} = 2.5 \times \left( \frac{d}{dt} (3 - 4.5 e^{-6t}) \right)$$

$$= 2.5 \left( 27 \times e^{-6t} \right) = 67.5 e^{-6t}$$

## Diode : 2 electrodes

→ p-type & n-type material sandwiched together forming depletion region b/w 2.

Si & Ge can be used

## Biasing of 2 diodes

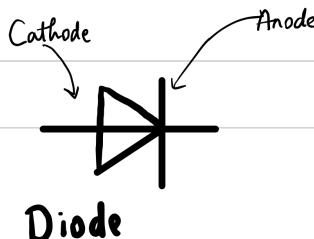
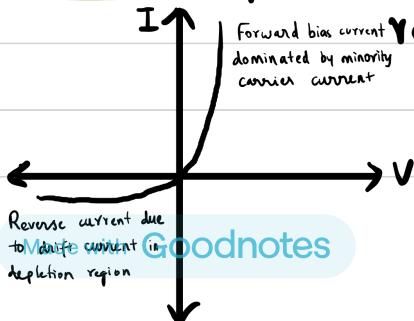
→ Forward Bias - Material type connected to **Same** polarity terminal of voltage source



→ Backward Bias - Material type connected to **opposite** polarity terminal of voltage source



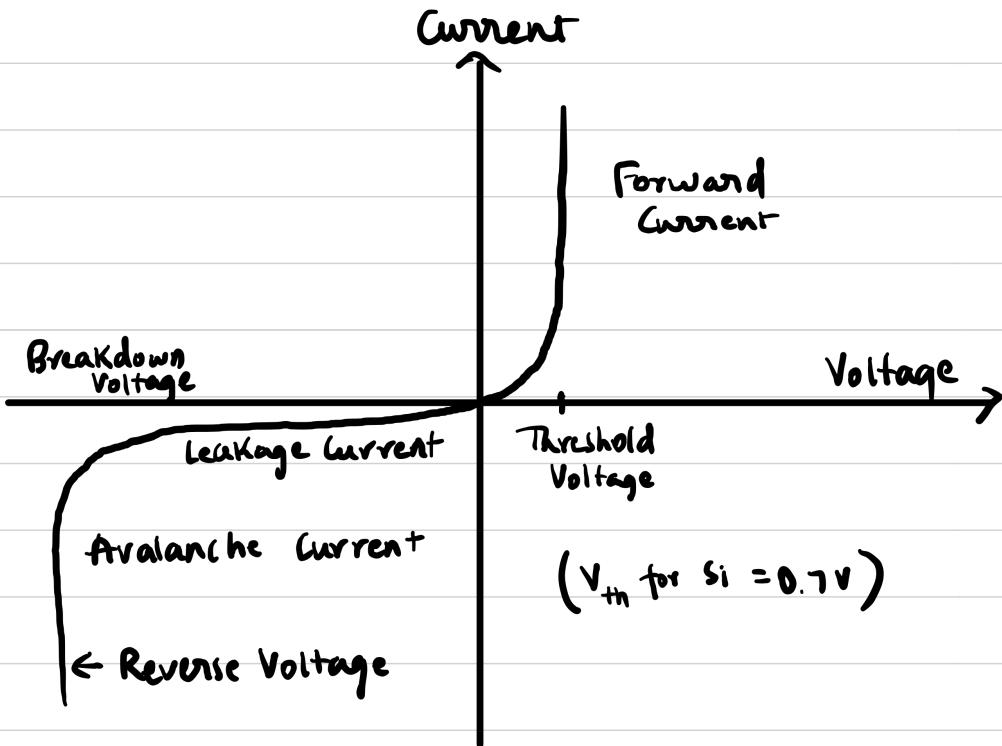
→ Knee Voltage - Minimum amount of voltage required to conduct the diode



## Shockley's Equation

$$\rightarrow I_D = I_s \left( e^{\frac{qV_D}{nKT}} - 1 \right) \Rightarrow \text{Ideal diode eq}$$

$I_D \Rightarrow$  Diode Current  
 $V_D \Rightarrow$  Diode Voltage  
 $q \Rightarrow$  charge on  $e^- = 1.6 \times 10^{-19} C$   
 $n \Rightarrow$  ideality factor ( $n=1 \Rightarrow$  indirect semicond  $\Rightarrow Si, Ge, Si_3N_4$   
 $n=2 \Rightarrow$  direct semicond  $\Rightarrow GaAs, InP, GaN$ )  
 $K \Rightarrow$  Boltzmann const  $(K = 1.38 \times 10^{-23} J/K)$



### Parameters :

#### Forward Bias

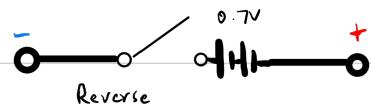
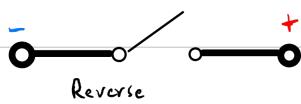
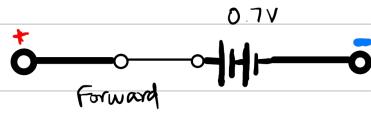
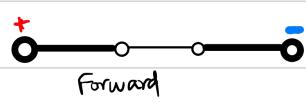
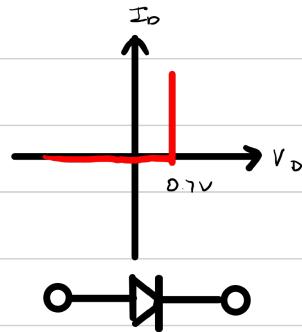
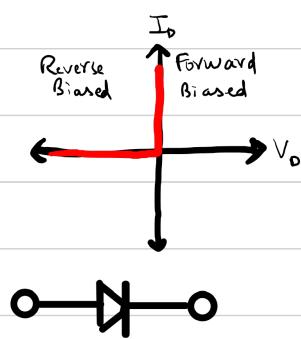
- Knee Voltage
- Forward Current Rating
- Max Power dissipation

#### Reverse Bias

- Reverse Saturation Current
- Break down Voltage
- Peak Inverse Voltage Rating

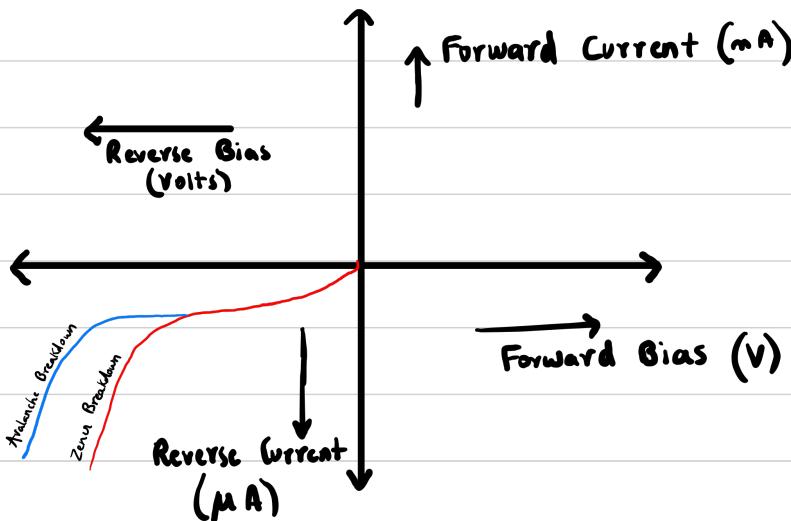
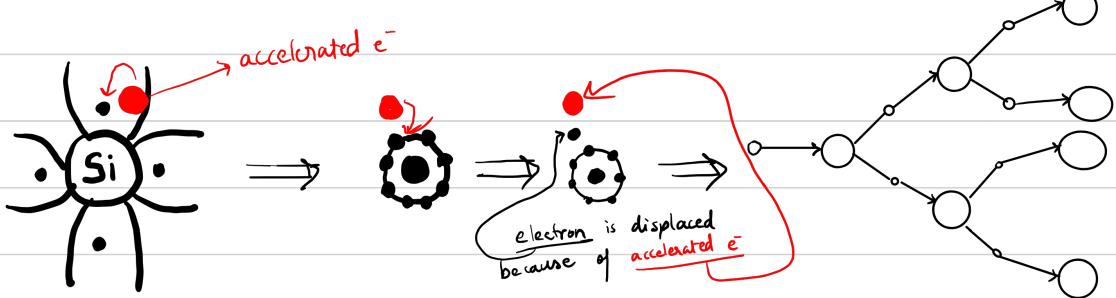
**Ideal Diode** → Forward bias  $\Rightarrow$  No resistance  $\Rightarrow$  Closed Switch  
Backward bias  $\Rightarrow$   $\infty$  "  $\Rightarrow$  Open Switch

**Practical Diode** → Forward bias  $\Rightarrow$  Conducts at knee voltage  
Reverse bias  $\Rightarrow$  No current (due to majority charge)  
Acts like open switch



# Avalanche Breakdown

- In Reverse bias condition, as Voltage increases, free charge carriers obtain velocity & associate K.E & release additional carriers through collision with other atomic structures
- Covalent bonds are broken & electron-hole is generated



## Diode Equivalent Circuit

- Mathematical method to approximate non linear behaviour of real diodes to enable calculations & circuit analysis
- 3 different equivalent circuits are used to analyse diode circuits :
  - i) Ideal Equivalent Circuit
  - ii) Simplified Equivalent Circuit
  - iii) Piece-wise linear equivalent circuit

## Ideal Equivalent Circuit

- Considered as forward bias diode  $\Rightarrow$  Closed switch  $\Rightarrow$  No voltage drop

backward bias diode  $\Rightarrow$  Open switch

Forward Bias

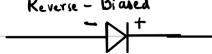


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Closed Switch (0V)

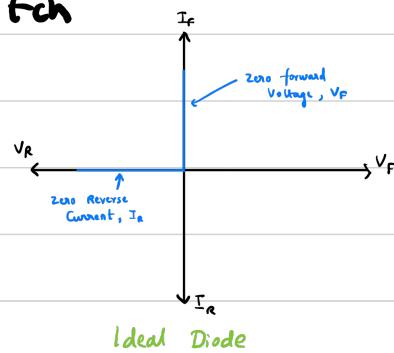


Reverse-Biased



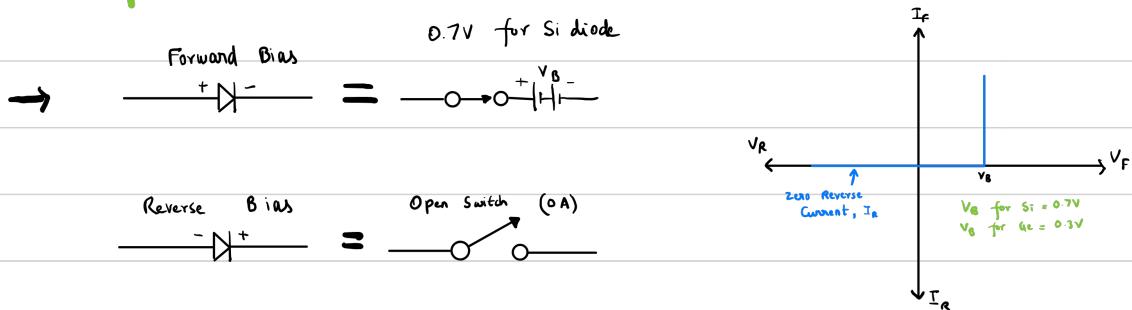
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Open Switch (0A)



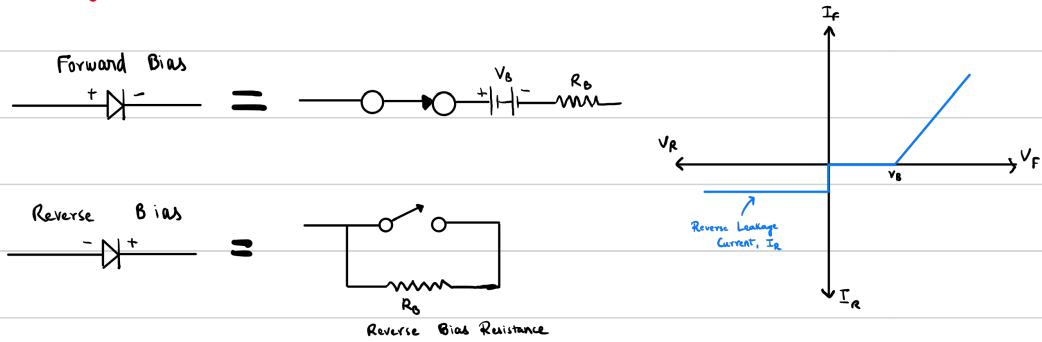
## Simplified Equivalent Circuit

- Diode is forward-biased diode in series w battery to turn on  
For Si diode,  $V \geq 0.7V$  required to turn it on.  
If less than 0.7V, it won't turn on.



## Piece-Wise Linear Equivalent Circuit

- Includes voltage across diode & voltage across Bulk resistance
- Voltage Drop,  $V_D = 0.7V + I_d \times R_B$



## Temperature Effects on V-I Characteristics Diode

- Effect of Temp. on diode is observed on both forward & reverse characteristics.
- Temp  $\uparrow \Rightarrow$  No. of  $e^-$  hole pair  $\uparrow \Rightarrow$  Conductivity  $\uparrow \Rightarrow$  Current  $\uparrow$
- PN junction diode parameters also depend on temp
  - i) Reverse Saturation Current
  - ii) Bias Current
  - iii) Reverse Breakdown Voltage
  - iv) Barrier Voltage
- Temp  $\uparrow \Rightarrow$  Carrier conc.  $\uparrow \Rightarrow$  Knee Voltage & Breakdown Voltage  $\downarrow$   
Reverse Saturation Current  $\uparrow$

### In forward Bias

Barrier Voltage decreases by  $2.5\text{mV}/1^\circ\text{C}$  for Ge & Si

### In reverse Bias

Reverse Saturation Current increases by  $7\%/\text{ }^\circ\text{C}$  for Ge & Si

almost doubles for every  $10^\circ\text{C}$  increase

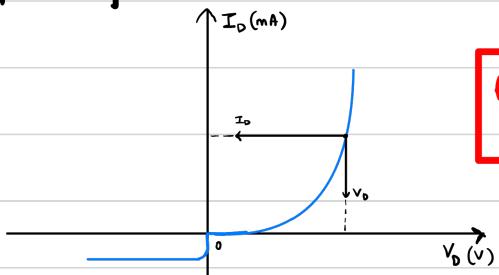
|   |   |
|---|---|
| en: $T = 20^\circ\text{C} \Rightarrow I_s = 0.1\mu\text{A}$ | $T = 50^\circ\text{C} \Rightarrow I_s = 0.8\mu\text{A}$ |
| $T = 30^\circ\text{C} \Rightarrow I_s = 0.2\mu\text{A}$     | $T = 60^\circ\text{C} \Rightarrow I_s = 1.6\mu\text{A}$ |
| $T = 40^\circ\text{C} \Rightarrow I_s = 0.4\mu\text{A}$     |   |

## Diode Resistance

- Actual Diode offers very small resistance ( $\neq 0$ ) in forward biased & called **forward resistance**
- Actual Diode offers very high resistance ( $\neq \infty$ ) in reverse biased & called **reverse resistance**
- 3 Types of Resistance levels based on applied Voltage
  - i) DC / Static Resistance
  - ii) AC / Dynamic Resistance
  - iii) Average AC Resistance

## DC Resistance

- Application of DC voltage to a circuit containing semiconductor diode will result in an **operating point** on semiconductor diode characteristic curve.
- If we find  $V_D$  &  $I_D$  at **operating point** gives DC resistance

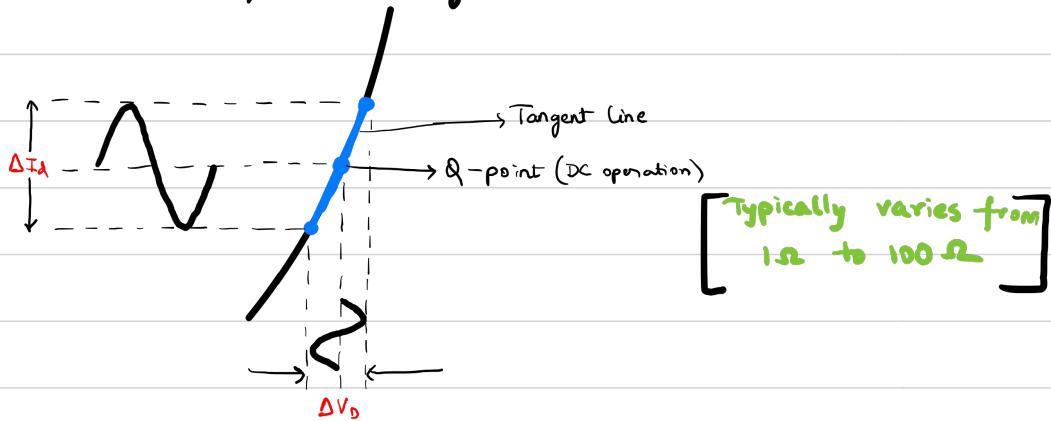


$$R_D = \frac{V_D}{I_D}$$

[Typically  
forward :  $10\Omega$  to  $80\Omega$   
reverse :  $10M\Omega$ ]

## AC Resistance

- Application of small AC voltage to a circuit containing semiconductor diode offers AC resistance
- A straight line tangent to curve through Q-point which defines the change in voltage & current to determine AC Resistance for this region  $r_d = \frac{\Delta V_d}{\Delta I_d}$



$$\rightarrow I_D = I_s \left( e^{\frac{qV_D}{kT}} - 1 \right) \Rightarrow I_0 + I_s = I_s e^{\frac{qV_0}{kT}}$$

Differentiate wrt  $V_D$

$$\frac{dI_D}{dV_D} = \frac{d}{dV_D} \left( I_s e^{\frac{qV_0}{kT}} \right) = I_s e^{\frac{qV_0}{kT}} \times \frac{q}{kT} = \left( \frac{I_0 + I_s}{kT} \right) \times q \approx \frac{I_0}{kT/q} \quad (I_0 \gg I_s)$$

$$r_d = \frac{dV_D}{dI_D} = \frac{kT/q}{I_0}$$

$$\text{At } 300 \text{ K} \Rightarrow \frac{kT}{q} = 26 \text{ mV}$$

$$r_d = \frac{26 \text{ mV}}{I_0}$$

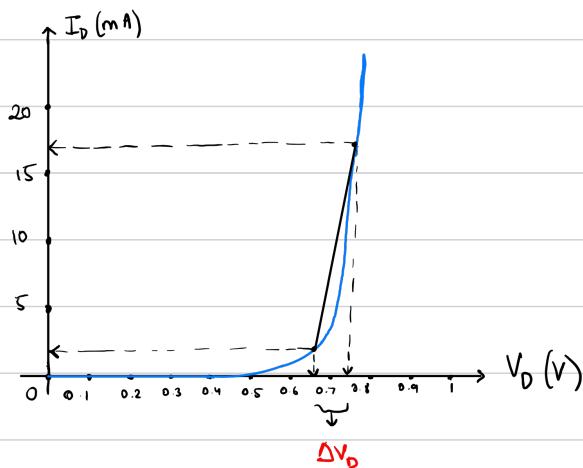
&

$$r'_d = \frac{26 \text{ mV}}{I_0} + r_B$$

Body Resistance

## Average AC Resistance

→ If applied input voltage is sufficiently large to produce a broad swing & resistance determined by straight line drawn b/w 2 intersections established by max & min values of input voltage



Q.

Determine the dc resistance levels for the diode of Fig. 1.26 at

- (a)  $I_D = 2 \text{ mA}$
- (b)  $I_D = 20 \text{ mA}$
- (c)  $V_D = -10 \text{ V}$

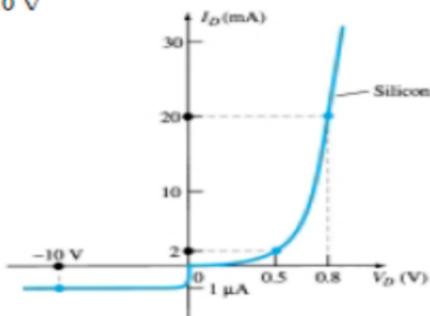


Figure 1.26 Example 1.1

A. i) at  $2 \text{ mA} \Rightarrow R = 0.5 \text{ V}$

$$R = \frac{V}{I} = \frac{0.5}{2 \times 10^{-3}} = 250 \Omega$$

ii) at  $20 \text{ mA} \Rightarrow R = 0.8 \text{ V}$

$$R = \frac{V}{I} = \frac{0.8}{20 \times 10^{-3}} = 40 \Omega$$

iii) at  $V_D = -10 \text{ V} \Rightarrow I_D = 1 \mu\text{A}$

$$R = \frac{V}{I} = \frac{10}{10^{-6}} = 10^7 \Omega \\ = 10 \text{ M}\Omega$$

# Series diode Configurations

- It is assumed that forward resistance of diode is usually so small compared to other series of elements that it is ignored.
- It is in 'on' state if current flows that it matches the direction of arrow in diode.

## Forward Bias

- $(V_D)_{Si} = 0.7V$
- $(V_D)_{Ge} = 0.3V$

## Analysis (For Si)

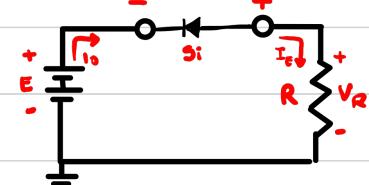
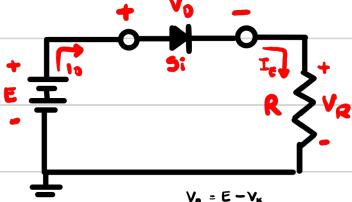
- $V_D = 0.7V$  (or)  $V_D = E$  if  $E < 0.7V$
- $V_R = E - V_D$
- $I_D = I_R = I_T = V_R/R$

## Reverse Bias

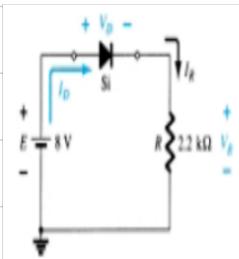
- Diodes behave as open circuits

## Analysis

- $V_D = E$ ;  $V_R = 0V$ ;  $I_D = 0A$



Q



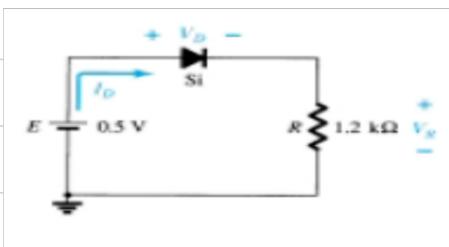
Find  $V_D$ ,  $V_R$  &  $I_D$

A.  $V_D = 0.7V$

$$V_R = 8 - 0.7 = 7.3V$$

$$I_D = I_R = \frac{7.3}{2.2k\Omega} = 3.32 \text{ mA}$$

Q



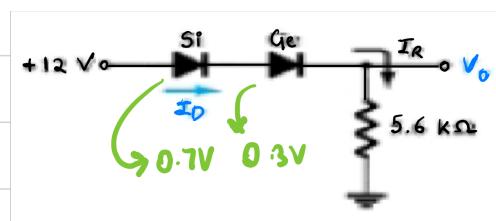
Find  $V_D$ ,  $V_R$ ,  $I_D$

A.  $V_D = 0.5V$

Not enough Voltage is supplied to turn on the silicon diode

$$V_R = 0V ; I_D = 0A$$

Q



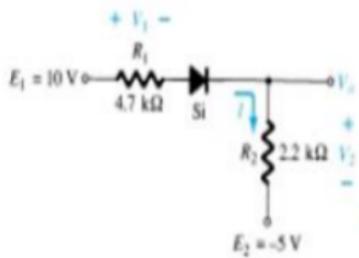
Find  $V_D$  &  $I_D$

A.  $V_D = E - V_{Si} - V_{Ge}$   
 $= 12 - 0.7 - 0.3$

$$= 11V$$

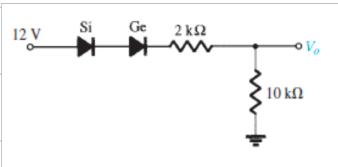
$$I_D = I_R = \frac{V_R}{R} = \frac{11}{5.6k\Omega} = 1.96 \text{ mA}$$

Q.



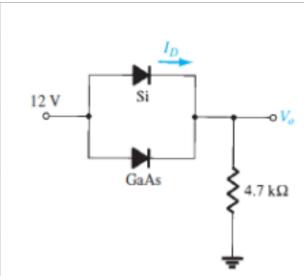
$$\begin{aligned}
 A. \quad I &= \frac{E_1 - E_2 - (0.7)}{R_1 + R_2} \\
 &= \frac{10 + 5 - 0.7}{(4.7 + 2.2) \times 10^3} \\
 &= \frac{14.3}{6.9} \times 10^{-3} = 2.07 \text{ mA}
 \end{aligned}$$

Q

Find  $V_0$ 

$$\begin{aligned}
 A. \quad V_0 &= \frac{(12 - 0.7 - 0.3) \times 10 \times 10^3}{(10 + 2) \times 10^3} \\
 &= 9.17 \text{ V}
 \end{aligned}$$

Q

Find  $I_D$  &  $V_D$ 

$$\begin{aligned}
 A. \quad I_R &= \frac{12 - 0.7}{4.7 \times 10^3} = \frac{11.3}{4.7} \times 10^{-3} \\
 &= 2.4 \text{ mA}
 \end{aligned}$$

$$I_D = I_R = 2.4 \text{ mA}$$

$$V_D = 12 - 0.7 = 11.3 \text{ V}$$

## BJT Transistor

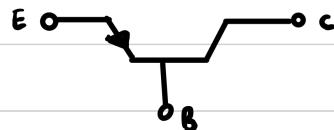
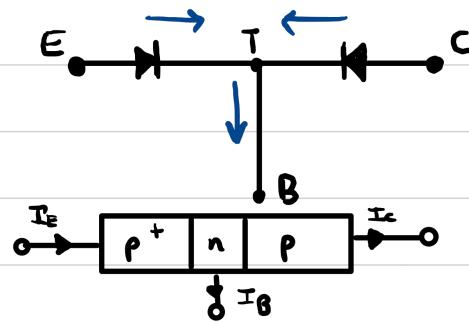
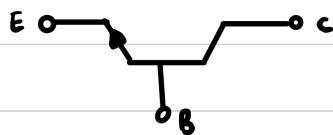
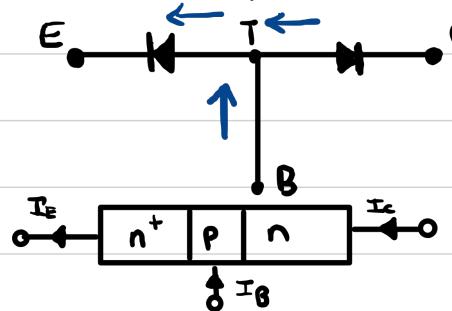
- A 3 Terminal device with p-type/n-type semiconductor sandwiched by the other
- Has 2 p-n junctions



- It requires active participation of both majority & minority carriers

→

Transfer + Resistor = Transistor



### Emitter

### Collector

### Base

- Heavily doped
- Moderate size

- Medium doping
- Largest size

- Minimum doping
- Smallest size

→ 2 p-n junctions

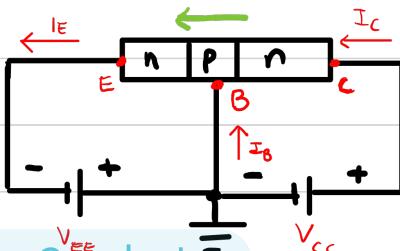
i) Emitter - Base → Forward

ii) Collector - Base → Reverse

| Regions of Operation  | E-B Junction | C-B Junction | Application         |
|-----------------------|--------------|--------------|---------------------|
| Active Region         | Forward      | Reverse      | Works as amplifier  |
| Saturation Region     | Forward      | Forward      | Works as ON switch  |
| Cut-off Region        | Reverse      | Reverse      | Works as OFF switch |
| Inverse active region | Reverse      | Forward      | Works as Attenuator |

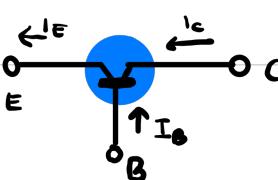
→ In a transistor,

$$I_E = I_C + I_B$$

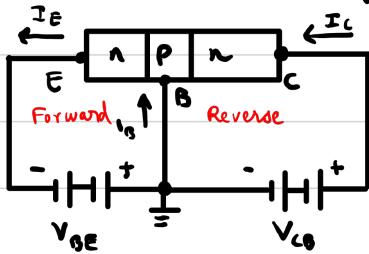


Can be :

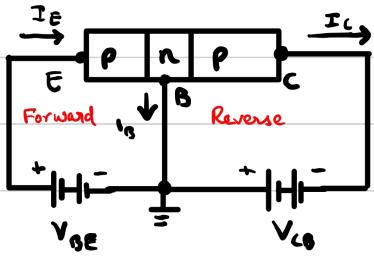
- i) Common Base Config
- ii) Common Emitter Config
- iii) Common Collector Config



## Common Base Configuration

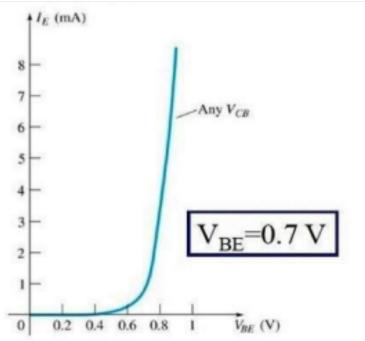


→ Requires 2 voltage sources  $V_{BE}$  &  $V_{CE}$   
in n-p-n  
↳ not pointing in

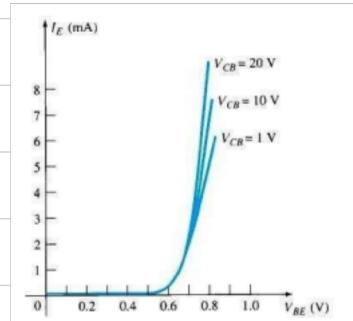


→ Requires 2 voltage sources  $V_{BE}$  &  $V_{CE}$   
in p-n-p  
↳ pointing in permanently

## Input Characteristics of BJT



$I_E$  v/s  $V_{BE}$  | For fixed  $V_{CE}$



$I_E$  v/s  $V_{BE}$  | For variable  $V_{CE}$

## Base Width Modulation / Early Effect

- BE junction is unchanged cuz  $V_{BE}$  is same ( $= 0.7V$ )
- Greater reverse bias across CB Junction increases CB depletion width.

There is variation in width of base in BJT  
cuz of variable  $V_{BC}$

↳ Causes 2 things :

- i) lesser recombination in smaller base
- ii) Change gradient increased across base & current of minority carriers across CB-junction increases called  $I_{CBO}$